Journal of Statistical Planning and Inference 33 (1992) 427–428
North-Holland

Author Index Volume 33 (1992)*

Athreya, K.B. and C.D. Fuh, Bootstrapping Markov chains: countable case (3) 311–331
Barry, R.P., Near-minimal resolution IV designs with three factors (3) 413–425
Blumenthal, S., *see* X.H. Zhou (3) 345–366
Brockwell, P.J. and J. Liu, Estimating the noise parameters from observations of a linear process with stable innovations (2) 175–186
Chaloner, K. and K. Larntz, Bayesian design for accelerated life testing (2) 245–259
Chen, H.-S., *see* W.-T. Huang (2) 187–196
Christensen, R. and J. Utts, Testing for nonadditivity in log-linear and logit models (3) 333–343
Clark, G.A., R.D. Hawkins and W.N. Frost, How neural are neural networks? A comparison of information processing and storage in artificial and real neural systems (1) 27– 65
Czado, C. and T. Santner, The effect of link misspecification on binary regression inference (2) 213–231
Durairajan, T.M., Optimal estimating function for non-orthogonal model (3) 381–384
Ebneshahrashoob, M., *see* M. Sobel (2) 157–164
Farmakis, N., On constructibility of A-optimal weighing designs $(n, k, 5)$, when $n \equiv 3 \pmod 4$ and $k = n-1, n$ (2) 275–383
Frost, W.N., *see* G.A. Clark (1) 27– 65
Fuh, C.D., *see* K.B. Athreya (3) 311–331
Habib, M.K., *see* E.J. Wegman (1) 5– 25
Habib, M.K. and A. Thavaneswaran, Optimal estimation for semimartingale neuronal models (1) 143–156
Hawkins, D.L., Detecting shifts in functions of multivariate location and covariance parameters (2) 233–244
Hawkins, R.D., *see* G.A. Clark (1) 27– 65
Heyde, C.C., New developments in inference for temporal stochastic processes (1) 121–129
Hsu, J.C., Stepwise Multiple Comparisons with the Best (2) 197–204
Huang, W.-T. and H.-S. Chen, Estimation of the exponential mean under type I censored sampling (2) 187–196
Huda, S. and R. Mukerjee, Further results on optimal designs with circular string property (3) 403–411
Jones, B., J. Kunert and H.P. Wynn, Information matrices for mixed effects models with applications to the optimality of repeated measurements designs (2) 261–274
Kollier, M., *see* S. Yakowitz (3) 295–309
Kunert, J., *see* B. Jones (2) 261–274
Larntz, K., *see* K. Chaloner (2) 245–259
Liu, J., *see* P.J. Brockwell (2) 175–186
McKenna, T.M., Physiological constraints on the formal representation of neurons (1) 67– 98
Mukerjee, R., *see* S. Sengupta (2) 285–293
Mukerjee, R., *see* S. Huda (3) 403–411
Paul, S.R. and K. Thiagarajah, Hypothesis tests for the one-way layout of type II censored data from Weibull populations (3) 367–380

* The issue number is given in front of page numbers.

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Pázman, A. and L. Pronzato, Nonlinear experimental design based on the distribution of estimators (3) 385–402
Pronzato, L., *see* A. Pázman (3) 385–402
Rom, D. and S.K. Sarkar, A generalized model for the analysis of association in ordinal contingency tables (2) 205–212
Różański, R., Recursive estimation of intensity function of a Poisson random field (2) 165–174
Santner, T., *see* C. Czado (2) 213–231
Sarkar, S.K., *see* D. Rom (2) 205–212
Sengupta, S. and R. Mukerjee, Optimal spatial sampling plans in the presence of linear trend (2) 285–293
Sobel, M. and M. Ebneshahrashoob, Quota sampling for multinomial via Dirichlet (2) 157–164
Starmer, C.F., Frequency-dependent processes: A model for short-term memory (1) 99–106
Swenberg, C.E., *see* G.L. Yang (1) 107–119
Thavaneswaran, A., *see* M.E. Thompson (1) 131–141
Thavaneswaran, A., *see* M.K. Habib (1) 143–156
Thiagarajah, K., *see* S.R. Paul (3) 367–380
Thompson, M.E. and A. Thavaneswaran, On Bayesian nonparametric estimation for stochastic processes (1) 131–141
Utts, J., *see* R. Christensen (3) 333–343
Wegman, E.J. and M.K. Habib, Stochastic methods for neural systems (1) 5– 25
Wynn, H.P., *see* B. Jones (2) 261–274
Yakowitz, S. and M. Kollier, Machine learning for optimal blackjack counting strategies (3) 295–309
Yang, G.L. and C.E. Swenberg, Estimation of open dwell time and problems of identifiability in channel experiments (1) 107–119
Zhou, X.H. and S. Blumenthal, Two stage reliability tests for new series systems (3) 345–366